

**Notice of References Cited**

Application/Control No.

09/769,490

Applicant(s)/Patent Under  
Reexamination  
ITOGA ET AL.

Examiner

Chih-Cheng Glen Kao

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6219400	04-2001	Hasegawa et al.	378/34
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	P	JP 06-194497	07-1994	Japan	Yanagihara et al.	G21K 1/06
	Q					
	R					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
X	U	Bearden et al., Reviews in Modern Physics [1967], v. 39, from <a href="http://www-structure.lln.gov/Xray/elements.html">http://www-structure.lln.gov/Xray/elements.html</a>
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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